

# Enhanced ESD, 3.0 kV rms 200Mbps Single-Channel Digital Isolators

Data Sheet  $\pi$ 110E3

#### **FEATURES**

Ultra-low power consumption (1Mbps): 0.75mA/Channel

High data rate: 200Mbps

High common-mode transient immunity: 75 kV/μs typical

High robustness to radiated and conducted noise

Low propagation delay:

8 ns typical for 5 V operation 9 ns typical for 3.3 V operation Isolation voltages: AC 3000Vrms

High ESD rating:

**ESDA/JEDEC JS-001-2017** 

Human body model (HBM) ±8kV

Safety and regulatory approvals:

UL certificate number: E494497

3000Vrms for 1 minute per UL 1577

CSA Component Acceptance Notice 5A VDE certificate number: 40053041

DIN VDE V 0884-11:2017-01

V<sub>IORM</sub> = 565V peak

CQC certification per GB4943.1-2011

3 V to 5.5 V level translation

Wide temperature range: -40°C to 125°C RoHS-compliant, NB SOIC-8 package

#### **APPLICATIONS**

General-purpose Single-channel isolation Industrial field bus Isolation Industrial automation systems Isolated switch mode supplies Isolated ADC, DAC Motor control

#### **GENERAL DESCRIPTION**

Intelligent voltage divider technology (*iDivider*® technology) is a new generation digital isolator technology invented by 2PaiSEMI. It uses the principle of capacitor voltage divider to transmit voltage signal directly cross the isolator capacitor without signal modulation and demodulation.

The  $\pi1xxxxx$  isolator data channels are independent and are available in a variety of configurations with a withstand voltage rating of 1.5 kV rms to 6.0 kV rms and the data rate from DC up to

600Mbps (see the Ordering Guide). The devices operate with the supply voltage on either side ranging from 3.0 V to 5.5 V, providing compatibility with lower voltage systems as well as enabling voltage translation functionality across the isolation barrier. The fail-safe state is available in which the outputs transition to a preset state when the input power supply is not applied.

#### **FUNCTIONAL BLOCK DIAGRAMS**

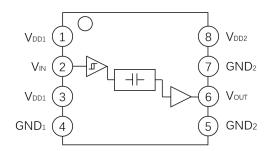


Figure 1.π110E3x functional Block Diagram

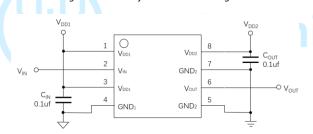


Figure  $2.\pi 110E3x$  Typical Application Circuit

# PIN CONFIGURATIONS AND FUNCTIONS

Table  $1.\pi 110E3x$  Pin Function Descriptions

Pin No.	Name	Description
1	V <sub>DD1</sub>	Supply Voltage for Isolator Side 1.
2	Vin	Logic Input.
3	V <sub>DD1</sub>	Supply Voltage for Isolator Side 1.
4	GND <sub>1</sub>	Ground 1. This pin is the ground reference for Isolator Side 1.
5	GND <sub>2</sub>	Ground 2. This pin is the ground reference for Isolator Side 2.
6	Vоит	Logic Output.
7	GND <sub>2</sub>	Ground 2. This pin is the ground reference for Isolator Side 2.
8	V <sub>DD2</sub>	Supply Voltage for Isolator Side 2.



Figure  $3.\pi110E3x$  Pin Configuration

# **ABSOLUTE MAXIMUM RATINGS**

 $T_A = 25$ °C, unless otherwise noted.

Table 2.Absolute Maximum Ratings<sup>4</sup>

Parameter	Rating		
Supply Voltages (V <sub>DD1</sub> -GND <sub>1</sub> , V <sub>DD2</sub> -GND <sub>2</sub> )	−0.5 V to +7.0 V		
Input Voltages <sup>1</sup>	$-0.5 \text{ V to V}_{DDx} + 0.5 \text{ V}$		
Output Voltages <sup>1</sup>	-0.5 V to V <sub>DDx</sub> + 0.5 V		
Average Output Current per Pin <sup>2</sup> Side 1 Output Current (I <sub>01</sub> )	-10 mA to +10 mA		
Average Output Current per Pin <sup>2</sup> Side 2 Output Current (I <sub>O2</sub> )	−10 mA to +10 mA		
Common-Mode Transients Immunity <sup>3</sup>	-200 kV/μs to +200 kV/μs		
Storage Temperature (T <sub>ST</sub> ) Range	-65°C to +150°C		
Ambient Operating Temperature (T <sub>A</sub> ) Range	-40°C to +125°C		

# **RECOMMENDED OPERATING CONDITIONS**

**Table 3. Recommended Operating Conditions** 

Parameter	Symbol	Min	Тур	Max	Unit
Supply Voltage	V <sub>DDx</sub> <sup>1</sup>	3		5.5	V
High Level Input Signal Voltage	$V_{IH}$	0.7*V <sub>DDx</sub> 1		$V_{DDx}^{1}$	V
Low Level Input Signal Voltage	$V_{IL}$	0		$0.3*V_{DDx}^{1}$	V
High Level Output Current	Іон	-6			mA
Low Level Output Current	Іоь			6	mA
Data Rate		0		200	Mbps
Junction Temperature	Τ <sub>J</sub>	-40		150	°C
Ambient Operating Temperature	T <sub>A</sub>	-40		125	°C

Notes

Notes

 $<sup>^{1}</sup>$  V<sub>DDx</sub> is the side voltage power supply V<sub>DD</sub>, where x = 1 or 2.

<sup>&</sup>lt;sup>2</sup> See Figure 4 for the maximum rated current values for various temperatures.

<sup>&</sup>lt;sup>3</sup> See Figure 11 for Common-mode transient immunity (CMTI) measurement.

<sup>&</sup>lt;sup>4</sup>Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

 $<sup>^{1}</sup>$  V<sub>DDx</sub> is the side voltage power supply V<sub>DD</sub>, where x = 1 or 2.

# **Truth Tables**

Table  $4.\pi110xxx$  Truth Table

V <sub>Ix</sub> Input <sup>1</sup>	V <sub>DDI</sub> State <sup>1</sup>	V <sub>DDO</sub> State <sup>1</sup>	Default Low	Default High	Test Conditions	
- vx mput	V DDI State	V <sub>DDO</sub> State	Vox Output1	Vox Output1	/Comments	
Low	Powered <sup>2</sup>	Powered <sup>2</sup>	Low	Low	Normal operation	
High	Powered <sup>2</sup>	Powered <sup>2</sup>	High	High	Normal operation	
Open	Powered <sup>2</sup>	Powered <sup>2</sup>	Low	High	Default output	
Don't Care⁴	Unpowered <sup>3</sup>	Powered <sup>2</sup>	Low	High	Default output <sup>5</sup>	
Don't Care <sup>4</sup>	Powered <sup>2</sup>	Unpowered <sup>3</sup>	High Impedance	High Impedance		

Notes:

# **SPECIFICATIONS**

#### **ELECTRICAL CHARACTERISTICS**

**Table 5.Switching Specifications** 

 $V_{DD1}$  -  $V_{GND1}$  =  $V_{DD2}$  -  $V_{GND2}$  = 3.3 $V_{DC}$ ±10% or 5 $V_{DC}$ ±10%,  $T_A$ =25°C, unless otherwise noted.

Parameter	Symbol	Min	Тур	Max	Unit	Test Conditions/Comments
Minimum Pulse Width	PW			5	ns	Within pulse width distortion (PWD) limit
Maximum Data Rate		200			Mbps	Within PWD limit
Duanastian Dalau Tima 1		5.5	8	12.5	ns	@ 5V <sub>DC</sub> supply
Propagation Delay Time <sup>1</sup>	t <sub>pHL</sub> , t <sub>pLH</sub>	6.5	9	13.5	ns	@ 3.3V <sub>DC</sub> supply
Pulse Width Distortion	PWD	0	0.3	3.0	ns	The max different time between tphL and tpLH@ 5VDC supply. And The value is   tpHL - tpLH
		0	0.3	3.0	ns	@ 3.3V <sub>DC</sub> supply
Part to Part Propagation Delay Skew	<b>t</b> PSK			2	ns	The max different propagation delay time between any two devices at the same temperature, load and voltage @ 5V <sub>DC</sub> supply
				2	ns	@ 3.3V <sub>DC</sub> supply
Output Signal Rise/Fall Time <sup>4</sup>	t <sub>r</sub> /t <sub>f</sub>		1.5		ns	See Figure 7.
Dynamic Input Supply Current per Channel	Iddi (d)		9		μΑ /Mbps	Inputs switching, 50% duty cycle square wave, CL = 0 pF @ 5V <sub>DC</sub> Supply
Dynamic Output Supply Current per Channel	IDDO (D)		38		μA /Mbps	Inputs switching, 50% duty cycle square wave, CL = 0 pF @ 5V <sub>DC</sub> Supply
Dynamic Input Supply Current per Channel	Iddi (d)		5		μΑ /Mbps	Inputs switching, 50% duty cycle square wave, CL = 0 pF @ 3.3V <sub>DC</sub> Supply
Dynamic Output Supply Current per Channel	Iddo (d)		23		μA /Mbps	Inputs switching, 50% duty cycle square wave, CL = 0 pF @ 3.3V <sub>DC</sub> Supply
Common-Mode Transient Immunity <sup>3</sup>	CMTI		75		kV/μs	$V_{IN} = V_{DDx}^2$ or 0V, $V_{CM} = 1000 \text{ V}$
littor			120		ps p-p	Coo the litter Massurement section
Jitter		20		ps rms	See the Jitter Measurement section	
ESD(HBM - Human body model)	ESD		±8		kV	

Notes:

<sup>1</sup> V<sub>Ix</sub>/V<sub>Ox</sub> are the input/output signals of a given channel (A or B). V<sub>DDI</sub>/V<sub>DDO</sub> are the supply voltages on the input/output signal sides of this given channel.

<sup>&</sup>lt;sup>2</sup> Powered means V<sub>DDx</sub>≥ 2.95 V

 $<sup>^{3}</sup>$  Unpowered means  $V_{DDx}$  < 2.30V

 $<sup>^4</sup>$  Input signal ( $V_{IX}$ ) must be in a low state to avoid powering the given  $V_{DDI}$  through its ESD protection circuitry.

<sup>&</sup>lt;sup>5</sup> If the V<sub>DDI</sub> goes into unpowered status, the channel outputs the default logic signal after around 1us. If the V<sub>DDI</sub> goes into powered status, the channel outputs the input status logic signal after around 1us.

 $<sup>^{1}</sup>$  t<sub>pLH</sub> = low-to-high propagation delay time, t<sub>pHL</sub> = high-to-low propagation delay time. See Figure 8.

 $<sup>^{2}</sup>$  V<sub>DDx</sub> is the side voltage power supply V<sub>DD</sub>, where x = 1 or 2.

<sup>&</sup>lt;sup>3</sup> See Figure 11 for Common-mode transient immunity (CMTI) measurement.

<sup>&</sup>lt;sup>4</sup>tr means is the time from 10% amplitude to 90% amplitude of the rising edge of the signal, tf means is the time from 90% amplitude to 10% amplitude of the falling edge of the signal.

**Table 6.DC Specifications** 

VDD1 - VGND1 = VDD2 - VGND2 = 3.3VDC±10% or 5VDC±10%, TA=25°C, unless otherwise noted.

	Symbol	Min	Тур	Max	Unit	Test Conditions/Comments
Rising Input Signal Voltage Threshold	V <sub>IT+</sub>		$0.6*V_{DDx}^1$	$0.7*V_{DDx}^{1}$	V	
Falling Input Signal Voltage Threshold	V <sub>IT</sub> -	0.3* V <sub>DDX</sub> <sup>1</sup>	0.4* V <sub>DDX</sub> <sup>1</sup>		V	
High Lovel Output Voltage	Von <sup>1</sup>	V <sub>DDx</sub> - 0.1	$V_{DDx}$		V	–20 μA output current
High Level Output Voltage	VOH -	V <sub>DDx</sub> - 0.2	$V_{DDx} - 0.1$		V	-2 mA output current
Law Laval Output Valtage	V-		0	0.1	V	20 μA output current
Low Level Output Voltage	Vol		0.1	0.2	V	2 mA output current
Input Current per Signal Channel	I <sub>IN</sub>	-10	0.5	10	μΑ	0 V ≤ Signal voltage ≤ V <sub>DDX</sub> <sup>1</sup>
V <sub>DDx</sub> <sup>1</sup> Undervoltage Rising Threshold	V <sub>DDxUV+</sub>	2.45	2.75	2.95	V	
V <sub>DDx</sub> <sup>1</sup> Undervoltage Falling Threshold	V <sub>DDxUV</sub> -	2.30	2.60	2.75	V	
V <sub>DDx</sub> <sup>1</sup> Hysteresis	VDDxUVH		0.15	·	V	

Notes:

Table 7. Quiescent Supply Current

VDD1 - VGND1 = VDD2 - VGND2 = 3.3VDC±10% or 5VDC±10%, TA=25°C, CL = 0 pF, unless otherwise noted.

Part	Symbol	Min	Time	Max	Unit	Test Conditions		
		IVIIII	Тур	IVIAX	Onit	Supply voltage	Input signal	
	I <sub>DD1</sub> (Q)	0.06	0.08	0.10	mA		VI=0V for π110E30	
	IDD2 (Q)	0.47	0.59	0.76	mA	5V <sub>DC</sub>	VI=5V for π110E31	
	I <sub>DD1</sub> (Q)	0.15	0.19	0.25	mA	⊃v <sub>DC</sub>	VI=5V for π110E30	
π110E3x	IDD2 (Q)	0.44	0.55	0.72	mA		VI=0V for $\pi$ 110E31	
#110E3X	I <sub>DD1</sub> (Q)	0.06	0.08	0.10	mA		VI=0V for π110E30	
	IDD2 (Q)	0.46	0.58	0.75	mA	2 21/	VI=3.3V for π110E31	
	IDD1 (Q)	0.11	0.14	0.18	mA	3.3V <sub>DC</sub>	VI=3.3V for π110E30	
	IDD2 (Q)	0.43	0.53	0.69	mA		VI=0V for π110E31	
•					•			

Table 8.Total Supply Current vs. Data Throughput (CL = 0 pF)

VDD1 - VGND1 = VDD2 - VGND2 = 3.3VDC±10% or 5VDC±10%, TA=25°C, CL = 0 pF, unless otherwise noted.

Part	Symbol	150 Kbps				10 Mbps			100 Mbps			Supply
	Syllibol	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit	voltage
π110E3x	I <sub>DD1</sub>		0.12	0.18		0.20	0.30		1.01	1.52	A	F)/
	I <sub>DD2</sub>		0.57	0.86		1.06	1.58		4.48	6.71	mA	5V <sub>DC</sub>
	I <sub>DD1</sub>		0.10	0.15		0.16	0.24		0.61	0.92	0	2.21/
	I <sub>DD2</sub>		0.56	0.84		0.86	1.29		2.93	4.39	mA	3.3V <sub>DC</sub>

#### **INSULATION AND SAFETY RELATED SPECIFICATIONS**

Table 9. Insulation Specifications

Parameter	Symbol	Value	Unit	Test Conditions/Comments
	39111501			,
Rated Dielectric Insulation Voltage		3000	V rms	1-minute duration
Minimum External Air Gap (Clearance)	L (CLR)	≥4	mm	Measured from input terminals to output terminals,
Willimidil External All Gap (Clearance)	L (CLK)	24	111111	shortest distance through air
Minimum Enternal Tradical (Consess)	1 (CDD)	≥4	mm	Measured from input terminals to output terminals,
Minimum External Tracking (Creepage)	L (CRP)			shortest distance path along body
Minimum Internal Gap (Internal Clearance)		≥11	μm	Insulation distance through insulation
Tracking Resistance (Comparative Tracking Index)	СТІ	>400	V	DIN EN 60112 (VDE 0303-11):2010-05
Material Group		II		IEC 60112:2003 + A1:2009

 $<sup>^{1}</sup>$  V<sub>DDx</sub> is the side voltage power supply V<sub>DD</sub>, where x = 1 or 2.

#### **PACKAGE CHARACTERISTICS**

Table 10.Package Characteristics

Parameter	Symbol	Typical Value	Unit	Test Conditions/Comments
Resistance (Input to Output) <sup>1</sup>	Rıo	$10^{11}$	Ω	
Capacitance (Input to Output) <sup>1</sup>	Сю	0.6	pF	@1MHz
Input Capacitance <sup>2</sup>	Cı	3.0	pF	@1MHz
IC Junction to Ambient Thermal	θја	100	°C/W	Thermocouple located at center of package
Resistance	OJA.	100	C/ VV	underside

Notes:

#### **REGULATORY INFORMATION**

See Table 11 for details regarding recommended maximum working voltages for specific cross isolation waveforms and insulation levels. Table 11.Regulatory

Regulatory	π110E3x
UL	Recognized under UL 1577 Component Recognition Program <sup>1</sup>
	Single Protection, 3000 V rms Isolation Voltage File (E494497)
VDE	DIN VDE V 0884-11:2017-01 <sup>2</sup> Basic insulation, $V_{IORM} = 565V$ peak, $V_{IOSM} = 3615 V$ peak File (40053041)
cqc	Certified under CQC11-471543-2012, GB4943.1-2011  Basic insulation at 500 V rms (707 V peak) working voltage Reinforced insulation at 250 V rms (353 V peak)  NB SOIC-8 File (CQC20001260211)

Notes:

## DIN V VDE V 0884-11 (VDE V 0884-11) INSULATION CHARACTERISTICS

Table 12.VDE Insulation Characteristics

Description	Test Conditions/Comments	Symbol	Characteristic	Unit
Installation Classification per DIN VDE 0110				
For Rated Mains Voltage ≤ 150 V rms			I to IV	
For Rated Mains Voltage ≤ 300 V rms			I to III	
For Rated Mains Voltage ≤ 400 V rms			I to III	
Climatic Classification			40/105/21	
Pollution Degree per DIN VDE 0110, Table 1			2	
Maximum repetitive peak isolation voltage		VIORM	565	Vpeak
Input to Output Test Voltage, Method B1	$V_{IORM} \times 1.5 = V_{pd (m)}, 100\%$ production test, $t_{ini} = t_m = 1$ sec, partial discharge < 5 pC	V <sub>pd</sub> (m)	848	Vpeak
Input to Output Test Voltage, Method A		V <sub>pd (m)</sub>		
After Environmental Tests Subgroup 1	$V_{IORM} \times 1.2 = V_{pd (m)}$ , $t_{ini} = 60$ sec, $t_m = 10$ sec, partial discharge < 5 pC	V <sub>pd (m)</sub>	678	Vpeak
After Input and/or Safety Test Subgroup 2 and Subgroup 3	$V_{IORM} \times 1.2 = V_{pd (m)}$ , $t_{ini} = 60$ sec, $t_m = 10$ sec, partial discharge < 5 pC		678	Vpeak
Highest Allowable Overvoltage		Vіотм	4200	Vpeak

<sup>&</sup>lt;sup>1</sup>The device is considered a 2-terminal device; SOIC-8 Pin 1 - Pin 4 are shorted together as the one terminal, and SOIC-8 Pin 5 - Pin 8 are shorted together as the other terminal.

<sup>&</sup>lt;sup>2</sup>Testing from the input signal pin to ground.

 $<sup>^{1}</sup>$  In accordance with UL 1577, each  $\pi$ 110E3x is proof tested by applying an insulation test voltage ≥ 3600 V rms for 1 sec

<sup>&</sup>lt;sup>2</sup> In accordance with DIN V VDE V 0884-11, each  $\pi$ 110E3x is proof tested by applying an insulation test voltage ≥ 848 V peak for 1 sec (partial discharge detection limit = 5 pC).

Description	Test Conditions/Comments	Symbol	Characteristic	Unit	
Surge Isolation Voltage Basic	Basic insulation, 1.2/50 $\mu$ s combination wave, VTEST = 1.3 $\times$ VIOSM (qualification) <sup>1</sup>	Viosm	3615	Vpeak	
Safety Limiting Values	Maximum value allowed in the event of a failure (see Figure 4)				
Maximum Safety Temperature		Ts	150	°C	
Maximum Power Dissipation at 25°C		Ps	1.25	W	
Insulation Resistance at T <sub>S</sub>	V <sub>IO</sub> = 500 V	$R_S$	>109	Ω	

Notes:

## **Typical Thermal Characteristic**

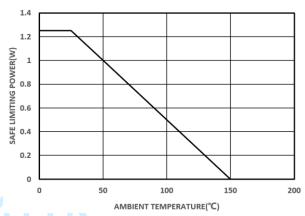


Figure 4.Thermal Derating Curve, Dependence of Safety Limiting Values with Ambient Temperature per VDE

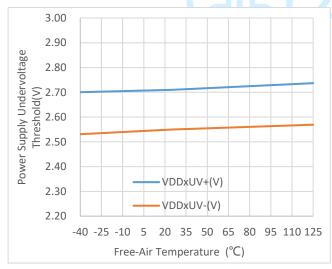


Figure 5.UVLO vs. Free-Air Temperature

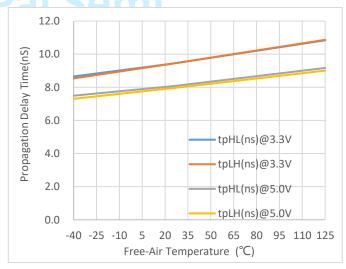


Figure 6. Propagation Delay Time vs. Free-Air Temperature

 $<sup>^{1}</sup>$ In accordance with DIN V VDE V 0884-11,  $\pi$ 1xxx3x is proof tested by applying a surge isolation voltage 4700 V.

# Timing test information

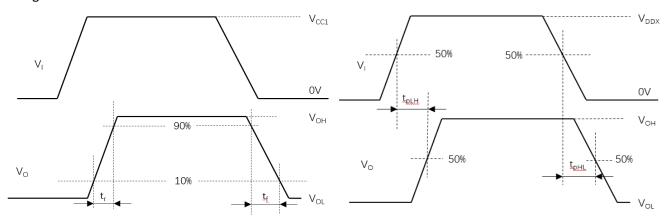


Figure 7.Transition time waveform measurement

Figure 8.Propagation delay time waveform measurement



# **APPLICATIONS INFORMATION**

#### **OVERVIEW**

The  $\pi 1 \times \times \times \times$  are 2PaiSemi digital isolators product family based on 2PaiSEMI unique *iDivider*® technology. Intelligent voltage **Divider** technology (*iDivider*® technology) is a new generation digital isolator technology invented by 2PaiSEMI. It uses the principle of capacitor voltage divider to transmit signal directly cross the isolator capacitor without signal modulation and demodulation. Compare to the traditional Opto-couple technology, icoupler technology, OOK technology, *iDivider*® is a more essential and concise isolation signal transmit technology which leads to greatly simplification on circuit design and therefore significantly improves device performance, such as lower power consumption, faster speed, enhanced anti-interference ability, lower noise.

By using maturated standard semiconductor CMOS technology and the innovative *iDivider*® design, these isolation components provide outstanding performance characteristics and reliability superior to alternatives such as optocoupler devices and other integrated isolators. The  $\pi1xxxxx$  isolator data channels are independent and are available in a variety of configurations with a withstand voltage rating of 1.5 kV rms to 6.0 kV rms and the data rate from DC up to 600Mbps (see the Ordering Guide).

The  $\pi 110E3x$  are the outstanding 200Mbps single-channel digital isolators with the enhanced ESD capability. the devices transmit data across an isolation barrier by layers of silicon dioxide isolation.

The devices operate with the supply voltage on either side ranging from 3.0 V to 5.5 V, offering voltage translation of 3.3 V, and 5 V logic. The  $\pi110E3x$  have very low propagation delay and high speed. The input/output design techniques allow logic and supply voltages over a wide range from 3.0 V to 5.5 V, offering voltage translation of 3.3 V,and 5 V logic. The architecture is designed for high common-mode transient immunity and high immunity to electrical noise and magnetic interference.

See the Ordering Guide for the model numbers that have the fail-safe output state of low or high.

#### **PCB LAYOUT**

The low-ESR ceramic bypass capacitors must be connected between  $V_{DD1}$  and  $GND_1$  and between  $V_{DD2}$  and  $GND_2$ . The bypass capacitors are placed on the PCB as close to the isolator device as possible. The recommended bypass capacitor value is between 0.1  $\mu F$  and 10  $\mu F$ . To enhance the robustness of a design, the user may also include resistors (50–300  $\Omega$ ) in series with the inputs and outputs if the system is excessively noisy.

Avoid reducing the isolation capability, Keep the space underneath the isolator device free from metal such as planes, pads, traces and vias.

To minimize the impedance of the signal return loop, keep the solid ground plane directly underneath the high-speed signal path, the closer the better. The return path will couple between the nearest ground plane to the signal path. Keep suitable trace width for controlled impedance transmission lines interconnect.

To reduce the rise time degradation, keep the length of input/output signal traces as short as possible, and route low inductance loop for the signal path and It's return path.

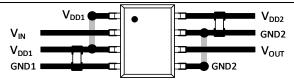


Figure 9. Recommended Printed Circuit Board Layout

#### JITTER MEASUREMENT

The eye diagram shown in the figure below provides the jitter measurement result for the  $\pi110\text{E}3x$ . The Keysight 81160A pulse function arbitrary generator works as the data source for the  $\pi110\text{E}3x$ , which generates 100Mbps pseudo random bit sequence (PRBS). The Keysight DSOS104A digital storage oscilloscope captures the  $\pi110\text{E}3x$  output waveform and recoveries the eye diagram with the SDA tools and eye diagram analysis tools. The result shows a typical measurement jitter data.

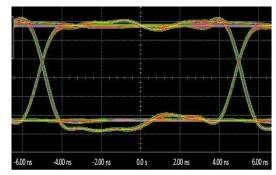


Figure  $10.\pi110E3x$  Eye Diagram

### **CMTI MEASUREMENT**

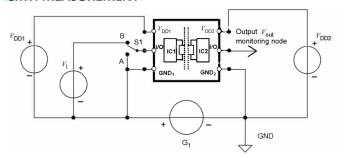


Figure 11.Common-mode transient immunity (CMTI) measurement

To measure the Common-Mode Transient Immunity (CMTI) of  $\pi 1xxxxx$  isolator under specified common-mode pulse magnitude (VCM) and specified slew rate of the common-mode pulse (dVCM/dt) and other specified test or ambient conditions, The common-mode pulse generator (G1) will be capable of providing fast rise and fall pulses of specified magnitude and duration of the common-mode pulse (VCM),such that the maximum common-mode slew rates (dVCM/dt) can be applied to  $\pi 1xxxxx$  isolator coupler under measurement. The common-mode pulse is applied between one side ground GND1 and the other side ground GND2 of  $\pi 1xxxxx$  isolator, and shall be capable of providing positive transients as well as negative transients.

# **OUTLINE DIMENSIONS**

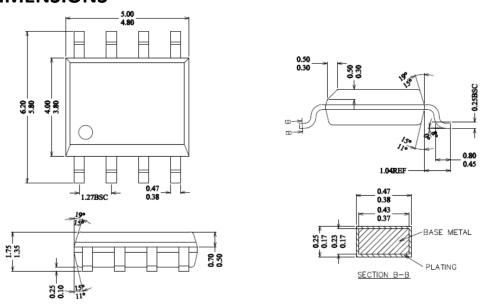


Figure 12. 8-Lead Narrow Body SOIC [NB SOIC-8] Package—dimension unit(mm)

# **Land Patterns**

8-Lead Narrow Body SOIC [NB SOIC-8]

The figure below illustrates the recommended land pattern details for the  $\pi$ 1xxxxx in an 8-pin narrow-body SOIC. The table below lists the values for the dimensions shown in the illustration.

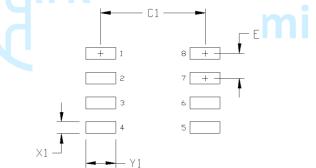


Figure 13.8-Lead Narrow Body SOIC [NB SOIC-8] Land Pattern

Table 13.8-Lead Narrow Body SOIC Land Pattern Dimensions

Dimension	Feature	Parameter	Unit	
C1	Pad column spacing	5.40	mm	
E	Pad row pitch	1.27	mm	
X1	Pad width	0.60	mm	
Y1	Pad length	1.55	mm	

#### Note:

<sup>1.</sup> This land pattern design is based on IPC -7351.

<sup>2.</sup>All feature sizes shown are at maximum material condition and a card fabrication tolerance of 0.05 mm is assumed.

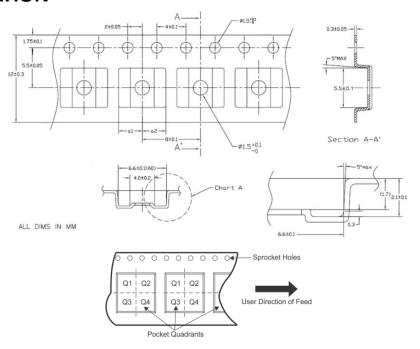
# **Top Marking**



Line 1	Product name	
Line 2	YY = Work Year	
	WW = Work Week	
	ZZ=Manufacturing code from assembly house	
Line 3	XXXX, no special meaning	

Figure 14.Top Making

# **REEL INFORMATION**



Note: The Pin 1of the chip is in the quadrant Q1 Figure 15.NB SOIC-8 Reel Information—dimension unit(mm)

# **ORDERING GUIDE**

Model Name <sup>1</sup>	Temperature Range	No. of Inputs, V <sub>DD1</sub> Side	No. of Inputs, V <sub>DD2</sub> Side	Isolation Rating (kV rms)	Fail-Safe Output State	Package	MSL Peak Temp <sup>2</sup>	MOQ/ Quantity per reel <sup>3</sup>
π110E31	-40~125°C	1	0	3	High	NB SOIC-8	Level-3-260C-168 HR	4000
π110E30	-40~125°C	1	0	3	Low	NB SOIC-8	Level-3-260C-168 HR	4000

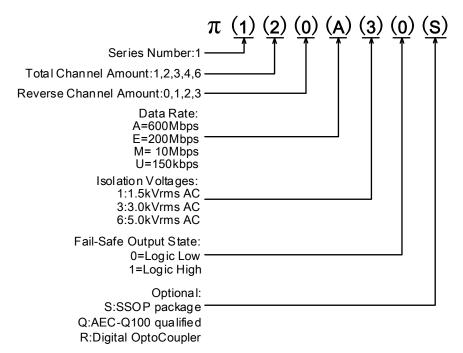
#### Note:

 $<sup>^{1}</sup>$  Pai1xxxxx is equals to  $\pi$ 1xxxxx in the customer BOM

<sup>&</sup>lt;sup>2</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>&</sup>lt;sup>3</sup> MOQ, minimum ordering quantity.

# PART NUMBER NAMED RULE



Notes:Pai1xxxxx is equals to  $\pi$ 1xxxxx in the customer BOM

Figure 16. Part Number Named Rule

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# **REVISION HISTORY**

Revision	Date	Page	Change Record			
1.0	2018/09/17	All	Initial version			
1.1	2018/11/28	P11	Changed the recommended bypass capacitor value.			
1.2	2019/09/08	Page1	Changed the contact address.  Add <i>iDivider</i> technology description in General Description.  Changed propagation delay time, CMTI and HBM ESD.  Added WB SOIC-16 Lead information.			
1.3	2019/12/20	Page1,11,14	Changed description of π1xxx6x.			
1.4	2020/02/16	Page1	Changed propagation delay time.			
1.5	2020/02/25	Page5	Changed Pulse Width Distortion.			
1.6	2020/03/16	Page6	Changed VDDx Undervoltage Threshold and Regulatory Information.  Added information of Land Patterns and Top Marking			
1.7	2020/04/16	Page12	Optimize description and format to make it consistent with the Chinese version.			
1.8	2021/05/17	Page 11	Changed part number named rule			



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